Automotive-grade N-channel 650 V, 70 mΩ typ., 38 A Power MOSFET MDmesh DM2 in a TO-247 package

TO-247

D(2, TAB)

G(1)

S(3)

NG1D2TS3Z

Features
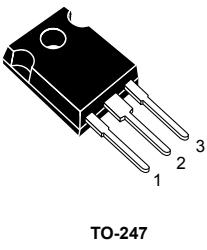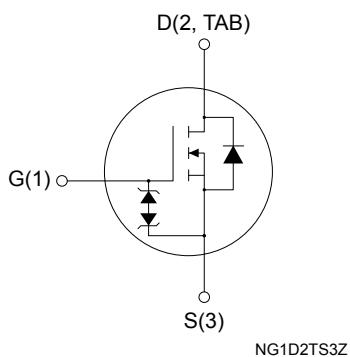
Order code	V_{DS}	$R_{DS(on)}$ max.	I_D
STW50N65DM2AG	650 V	87 mΩ	38 A

- AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

- Switching applications

Description

This high-voltage N-channel Power MOSFET is part of the MDmesh DM2 fast-recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high-efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Product status link
STW50N65DM2AG

Product summary[1]	
Order code	STW50N65DM2AG
Marking	50N65DM2
Package	TO-247
Packing	Tube

1. The HTRB test was performed at 80% $V_{(BR)DSS}$ in compliance with AEC-Q101 rev. C. All the other tests were performed according to rev. D.

DS11149 - Rev 3 - August 2020
For further information contact your local STMicroelectronics sales office.

www.st.com

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage (static)	±25	V
	Gate-source voltage (dynamic AC (f > 1 Hz))	±30	
I_D	Drain current (continuous) at T_C = 25 °C	38	A
	Drain current (continuous) at T_C = 100 °C	24	
I_{DM} [1]	Drain current (pulsed)	152	A
P_{TOT}	Total power dissipation at T_C = 25 °C	300	W
dv/dt[2]	Peak diode recovery voltage slope	100	V/ns
di/dt[2]	Peak diode recovery current slope	1000	A/µs
dv/dt[3]	MOSFET dv/dt ruggedness	100	V/ns
T_{stg}	Storage temperature	-55 to 150	°C
T_J	Operating junction temperature		

1. *Pulse width is limited by safe operating area.*
2. *$I_{SD} \leq 38$ A, V_{DS} peak < $V_{(BR)DSS}$, V_{DD} = 80% $V_{(BR)DSS}$.*
3. *$V_{DS} \leq 520$ V.*

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj\text{-}case}$	Thermal resistance junction-case	0.42	°C/W
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient	50	°C/W

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I_{AR}	Avalanche current, repetitive or not repetitive	7.5	A
E_{AS} [1]	Single pulse avalanche energy	850	mJ

1. *Starting T_J = 25 °C, $I_D = I_{AR}$, V_{DD} = 50 V.*

2   Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	650			V
I_{DSS}	Zero gate voltage drain current	V_{GS} = 0 V, V_{DS} = 650 V			10	μA
		V_{GS} = 0 V, V_{DS} = 650 V, T_C = 125 °C[1]			100	
I_{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = ±25 V			±5	μA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 250 μA	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	V_{GS} = 10 V, I_D = 19 A		70	87	mΩ

1. *Defined by design, not subject to production test.*

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0 V	-	3200	-	pF
C_{oss}	Output capacitance		-	130	-	pF
C_{rss}	Reverse transfer capacitance		-	3	-	pF
$C_{oss\ eq.}$ [1]	Equivalent output capacitance	V_{DS} = 0 to 520 V, V_{GS} = 0 V	-	256	-	pF
R_G	Intrinsic gate resistance	f = 1 MHz, I_D = 0 A	-	4	-	Ω
Q_g	Total gate charge	V_{DD} = 520 V, I_D = 38 A, V_{GS} = 0 to 10 V	-	69	-	nC
Q_{gs}	Gate-source charge	(see Figure 14. Test circuit for gate charge behavior)	-	18	-	nC
Q_{gd}	Gate-drain charge		-	34	-	nC

1. *$C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.*

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	V_{DD} = 325 V, I_D = 19 A,	-	22.5	-	ns
t_r	Rise time	R_G = 4.7 Ω, V_{GS} = 10 V	-	21	-	ns
$t_{d(off)}$	Turn-off delay time	(see Figure 13. Test circuit for resistive load switching times and	-	89	-	ns
t_f	Fall time	Figure 18. Switching time waveform)	-	10.5	-	ns

Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		38	A
I_{SDM} [1]	Source-drain current (pulsed)		-		152	A
V_{SD} [2]	Forward on voltage	V_{GS} = 0 V, I_{SD} = 38 A	-		1.6	V
t_{rr}	Reverse recovery time	I_{SD} = 38 A, di/dt = 100 A/μs,	-	150		ns
Q_{rr}	Reverse recovery charge	V_{DD} = 60 V	-	0.96		μC
I_{RRM}	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	12.8		A
t_{rr}	Reverse recovery time	I_{SD} = 38 A, di/dt = 100 A/μs,	-	245		ns
Q_{rr}	Reverse recovery charge	V_{DD} = 60 V, T_J = 150 °C	-	2.7		μC
I_{RRM}	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	22		A

1. Pulse width is limited by safe operating area.

2. Pulse test: pulse duration = 300 μs, duty cycle 1.5%.

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area
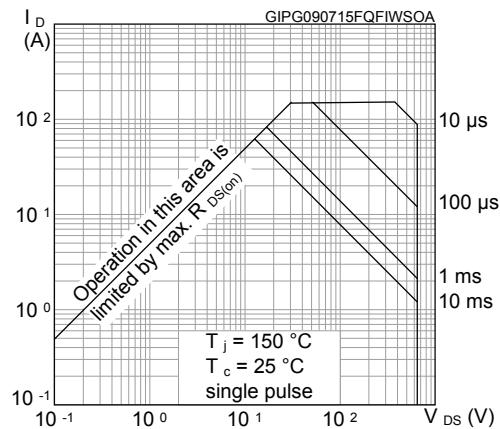
Figure 2. Thermal impedance
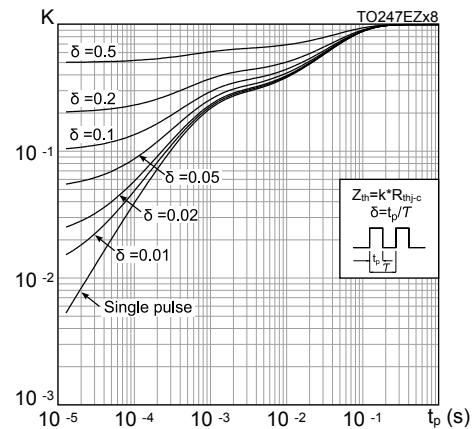
Figure 3. Output characteristics
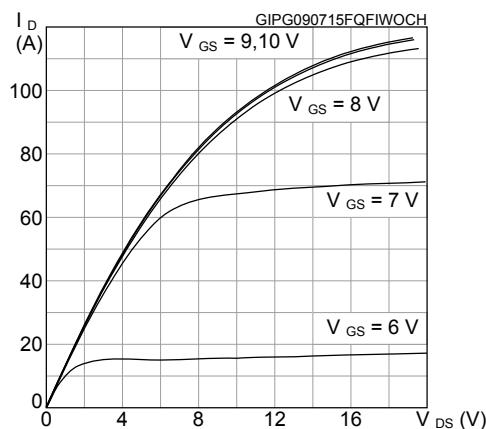
Figure 4. Transfer characteristics
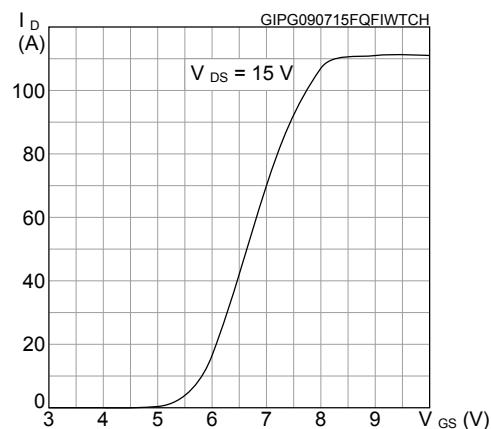
**Figure 5. Gate charge vs gate-source voltage**
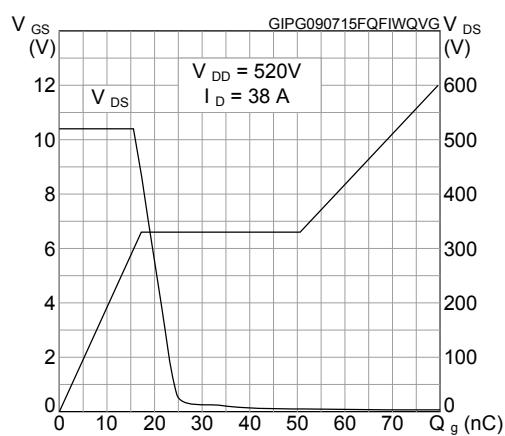


Figure 6. Static drain-source on-resistance
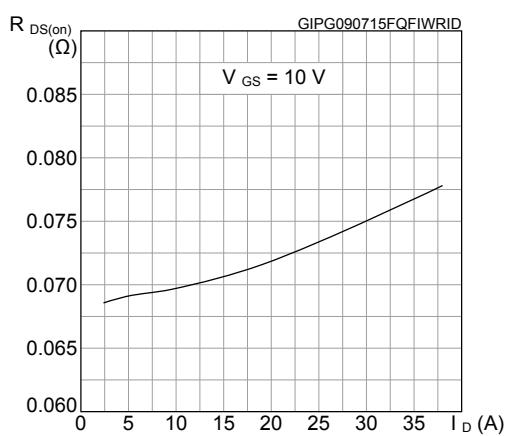
Figure 7. Capacitance variations
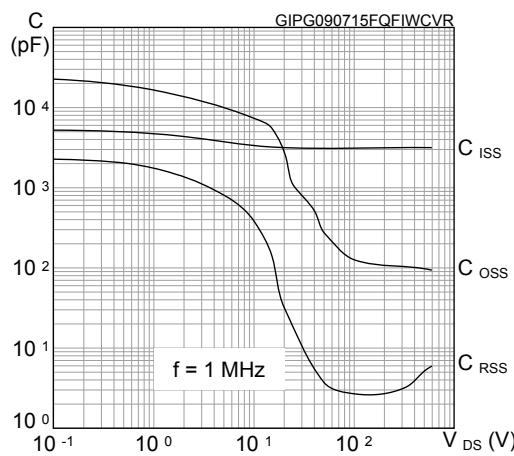
Figure 8. Normalized gate threshold voltage vs temperature
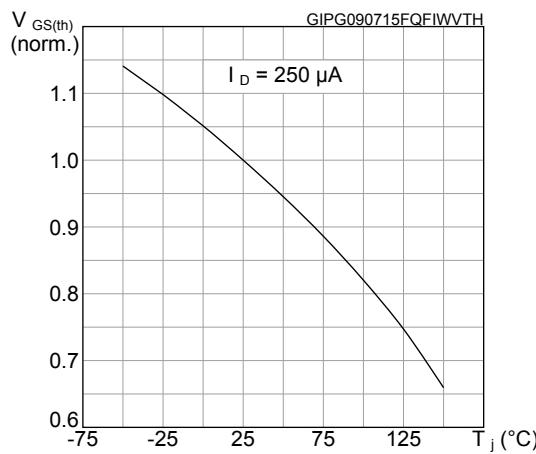


**Figure 9. Normalized on-resistance vs temperature**
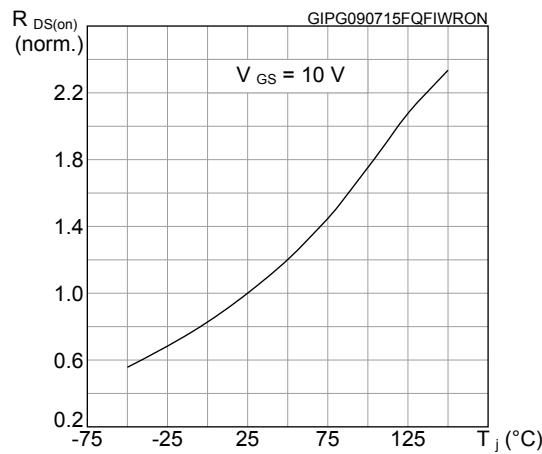
Figure 10. Normalized $V_{(BR)DSS}$ vs temperature
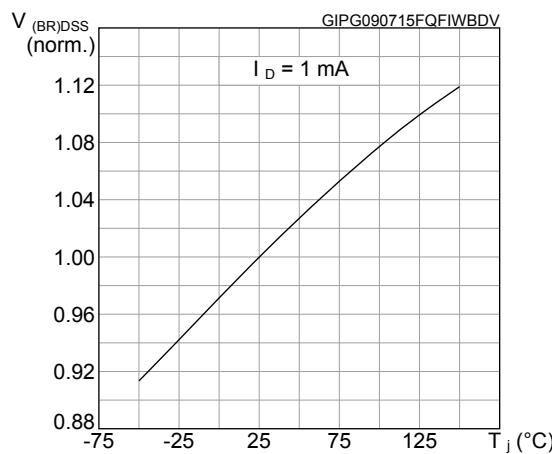
**Figure 11. Output capacitance stored energy**
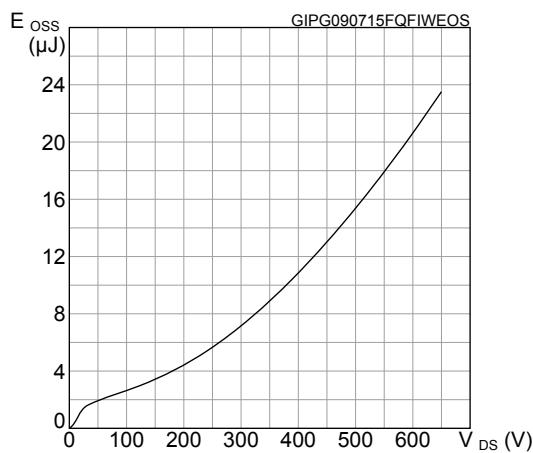
**Figure 12. Source-drain diode forward characteristics**
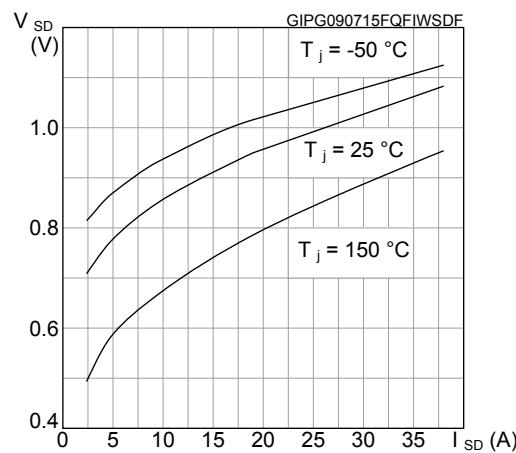
3 Test circuits

Figure 13. Test circuit for resistive load switching times
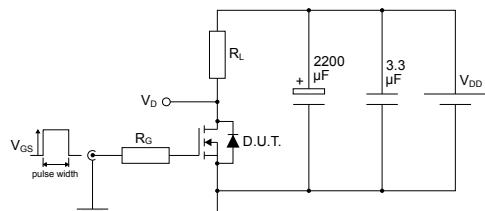

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**Figure 14. Test circuit for gate charge behavior**
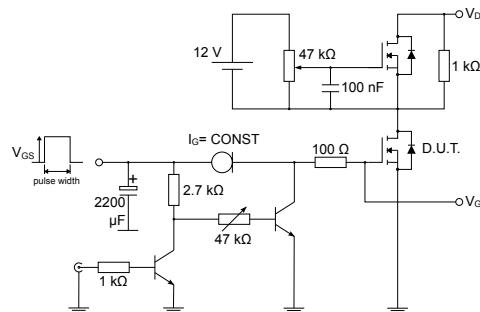
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**Figure 15. Test circuit for inductive load switching and diode recovery times**
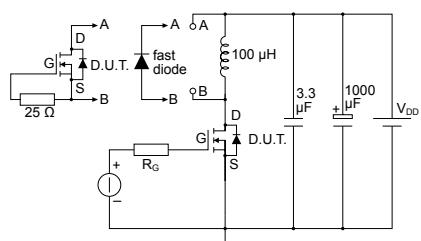
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Figure 16. Unclamped inductive load test circuit
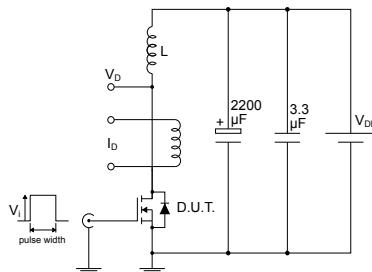
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Figure 17. Unclamped inductive waveform
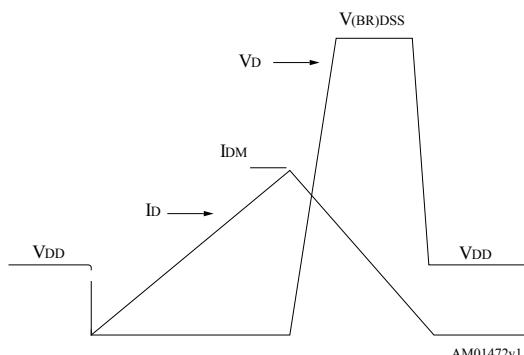
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Figure 18. Switching time waveform
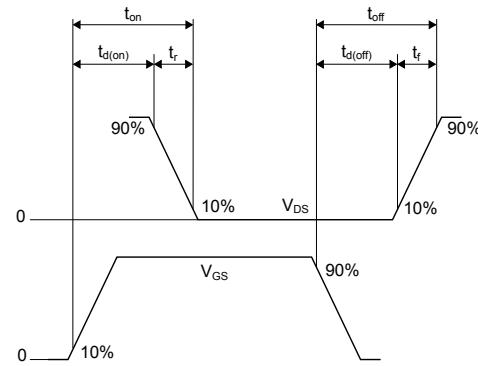
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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO-247 package information

Figure 19. TO-247 package outline
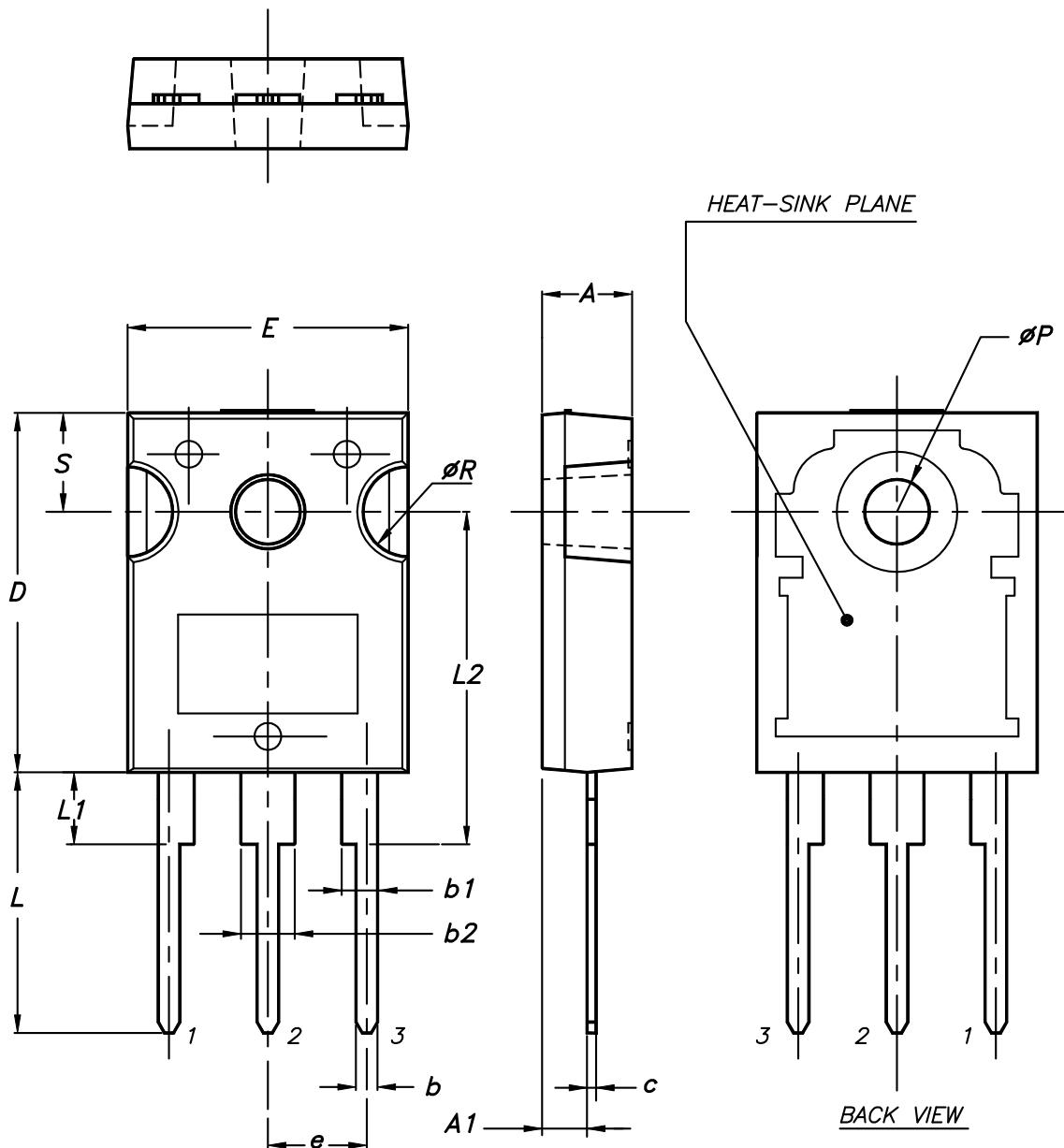
0075325_9

Table 8. **TO-247 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Revision history

Table 9. Document revision history

Date	Revision	Changes
09-Jul-2015	1	Initial release.
20-Dec-2017	2	Modified *Table 2: "Absolute maximum ratings"*, *Table 4: "Avalanche characteristics"* and *Table 8: "Source-drain diode"*. Modified *Figure 2: "Safe operating area"*. Minor text changes.
31-Aug-2020	3	Updated Table 1. Absolute maximum ratings. Minor text changes.

Contents

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